L Number	Hits	Search Text	DB	Time stamp
3	12	(29/846,842,884).ccls. and (wet adj etching) and (probe or contact or electrode) and testing	USPAT; US-PGPUB; IBM_TDB	2003/05/12 11:33
4	17	(438/17).ccls. and (wet adj etching) and (probe or contact or electrode) and testing	USPAT; US-PGPUB; IBM_TDB	2003/05/12 11:34
5	0	(261/11).ccls. and (wet adj etching) and (probe or contact or electrode) and testing	USPAT; US-PGPUB; IBM_TDB	2003/05/12 11:35
6	0	(261/11).ccls.	USPAT; US-PGPUB; IBM_TDB	2003/05/12 11:34
7	266	(216/11).ccls.	USPAT; US-PGPUB; IBM_TDB	2003/05/12 11:35
8	9	(216/11).ccls. and (wet adj etching) and (probe or contact or electrode) and testing	USPAT; US-PGPUB; IBM_TDB	2003/05/12 11:35
11	0	(205/667).ccls. and (wet adj etching) and (probe or contact or electrode) and testing	USPAT; US-PGPUB; IBM_TDB	2003/05/12 11:36
12	65	(205/667).ccls.	USPAT; US-PGPUB; IBM_TDB	2003/05/12 11:36
-	1	5105537.pn.	USPAT; US-PGPUB; IBM_TDB	2003/05/09 11:01
-	14	5105537.URPN.	USPAT	2003/05/09 11:02
-	13	("3634807" | "3725845" | "3881799" | "4050756" | "4208242" | "4240198" | "4253908" | "4398994" | "4604644" | "4644130" | "4746399" | "4751563" | "4940510").PN.	USPAT	2003/05/09 11:04
-	40	5220725.URPN.	USPAT	2003/05/09 11:08
-	33	("3293509" | "3776752" | "3789471" | "3871008" | "3970887" | "3998678" | "4163949" | "4172912" | "4178531" | "4407695" | "4513308" | "4551649" | "4663559" | "4664748" | "4685996" | "4701366" | "4721885" | "4818914" | "4857161" | "4857799" | "4901028" | "4902930" | "4906840" | "4912822" | "4940916" | "4956574" | "4983878" | "5019003" | "5047830" | "5064396" | "5105537" | "5118299" | "5137461").PN.	USPAT	2003/05/09 11:17
-	1	("5753130").PN.	USPAT; US-PGPUB; IBM_TDB	2003/05/09 11:21
-	16592	wet adj etching	USPAT; US-PGPUB; IBM_TDB	2003/05/09 13:28
-	3784	sharp adj tip	USPAT; US-PGPUB; IBM_TDB	2003/05/09 12:42
-	15	sharp adj tip adj electrode	USPAT; US-PGPUB; IBM_TDB	2003/05/09 12:44
-	350778	electrode	USPAT; US-PGPUB; IBM_TDB	2003/05/09 12:43
-	5051	(sharp or tip) adj electrode	USPAT; US-PGPUB; IBM_TDB	2003/05/09 12:44
-	415	((sharp or tip) adj electrode) and (etch or etching)	USPAT; US-PGPUB; IBM_TDB	2003/05/09 12:44
-	40	((sharp or tip) adj electrode) and (wet adj (etch or etching))	USPAT; US-PGPUB; IBM_TDB	2003/05/09 12:49

-	13051	electrode and (wet adj (etch or etching))	USPAT; US-PGPUB; IBM_TDB	2003/05/09 12:49
-	24	((projected or projection) adj electrode) and (wet adj (etch or etching))	USPAT; US-PGPUB; IBM_TDB	2003/05/09 12:49
-	72	5391259.URPN.	USPAT	2003/05/09 12:53
-	1	5105537.pn.	USPAT; US-PGPUB; IBM_TDB	2003/05/09 12:56
-	14	5105537.URPN.	USPAT	2003/05/09 12:56
-	13	("3634807" | "3725845" | "3881799" | "4050756" | "4208242" | "4240198" | "4253908" | "4398994" | "4604644" | "4644130" | "4746399" | "4751563" | "4940510").PN.	USPAT	2003/05/09 12:59
-	15	5245248.URPN.	USPAT	2003/05/09 13:00
-	396	29/884.ccls.	USPAT; US-PGPUB; IBM_TDB	2003/05/09 13:04
-	38	29/884.ccls. and electrode	USPAT; US-PGPUB; IBM_TDB	2003/05/09 13:05
-	14	5105537.URPN.	USPAT	2003/05/09 13:09
-	12436	(wet adj etching) and contact	USPAT; US-PGPUB; IBM_TDB	2003/05/09 13:11
-	2080	(wet adj etching) and ((conductive or electrical) adj contact)	USPAT; US-PGPUB; IBM_TDB	2003/05/09 13:12
-	14	(wet adj etching) and detachable and ((conductive or electrical) adj contact)	USPAT; US-PGPUB; IBM_TDB	2003/05/09 13:13
-	1909	(wet adj etching) and (remove or removed or removable or detachable) and ((conductive or electrical) adj contact)	USPAT; US-PGPUB; IBM_TDB	2003/05/09 13:14
-	140	(wet adj etching) and ((remove or removed or removable or detachable) with (conductive or electrical) adj contact)	USPAT; US-PGPUB; IBM_TDB	2003/05/09 13:23
-	7	(wet adj etching) and ((remove or removed or removable or detachable) with (conductive or electrical) adj (electrode or probe))	USPAT; US-PGPUB; IBM_TDB	2003/05/09 13:28
-	14	5105537.URPN.	USPAT	2003/05/09 13:43
-	13	("3634807" | "3725845" | "3881799" | "4050756" | "4208242" | "4240198" | "4253908" | "4398994" | "4604644" | "4644130" | "4746399" | "4751563" | "4940510").PN.	USPAT	2003/05/09 13:27
-	1	(wet adj etching) and ((remove or removed or removable or detachable) with (conductive or electrical or testing) adj (tip))	USPAT; US-PGPUB; IBM_TDB	2003/05/09 13:30
-	0	(wet adj etching) and ((remove or removed or removable or detachable) with (conductive or electrical or testing) adj (projection))	USPAT; US-PGPUB; IBM_TDB	2003/05/09 13:31
-	0	(wet adj etching) and ((remove or removed or removable or detachable) with (conductive or electrical or testing) adj (pin))	USPAT; US-PGPUB; IBM_TDB	2003/05/09 13:32
-	28	(wet adj etching) and ((conductive or electrical or testing) adj (pin))	USPAT; US-PGPUB; IBM_TDB	2003/05/09 13:42
-	2	29/884.ccls. and (wet adj etching)	USPAT; US-PGPUB; IBM_TDB	2003/05/09 13:42
-	1	5105537.PN.	USPAT	2003/05/09 13:43
-	60	205/667.ccls.	USPAT	2003/05/09 13:45
-	39	205/667.ccls. and etching	USPAT	2003/05/09 13:45
-	5	205/667.ccls. and (wet adj etching)	USPAT	2003/05/09 13:46

-	1058	216/$.ccls. and (wet adj etching)	USPAT	2003/05/09 13:47
-	831	216/$.ccls. and (wet adj etching) and (probe or contact or electrode)	USPAT	2003/05/09 13:47
-	69	216/$.ccls. and (wet adj etching) and (probe or contact or electrode) and testing	USPAT	2003/05/09 13:48
-	44	4952272.URPN.	USPAT	2003/05/09 13:53
-	44	4952272.URPN.	USPAT	2003/05/09 13:55
-	48999	probe and testing	USPAT; US-PGPUB; IBM_TDB	2003/05/12 09:52
-	44	4952272.URPN.	USPAT	2003/05/12 09:52